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Requisition form for using the facility at CIF: Transmission electron Microscopy (HRTEM)

nequi	isition form for using the facility at cir.	Transmission electron wicroscopy (Tikrew)
1)) <u>User details:</u>	Date :-
	Supervisor's Name	
	User's Name:	
	User's Tel. No.(mobile):	Supervisor's Signature
	Email ID :	(with seal)
2)	Measurement instructions for the operator:	Name & Department
-)	weasurement instructions for the operator.	
	i) Are your samples ready?	
	ii) Are your samples magnetic/magnetic	oxides
	iii) Have you transferred your samples or	nto the grids
	iv) Specify the nature of your sample	Nano crystalline Powders Polymer/composites (Thin films on substrate) – cross sections Thin films deposited on grids Biological samples
	v) Specify the expected chemical Name/or vi) Any preference to work at a certain K	ilo-Volt range
4)	What studies do you wish to make (Please Tic	k) Electron Diffraction Normal TEM High resolution TEM EDAX
5)	No. of samples (Restricted to 4 samples per appl	등 내용하다 내용하다 중요 그래프리시아 그 사람이 되는 사람들은 그리고 그림을 하다 하는 사람들이 되었다.
		imple fails due to some reason, you can check the other one. advance, prior to the day, booked for his /her measurements
Instru	uctions for the users	
i) U:	User must report at the HRTEM lab by 9:30 AM on the day allotted for his measurement/analysis.	
	The Engineer will mount your sample and help you with the TEM analysis. On the Tentative booking date will be given the user should be present during the measurements,	
	on the <u>Tentative booking date will be given</u> the user and collects the date on their CD at the end of the me	
	(Please fill all the necessary information	on)
Rema	rks	
Signat	ture of USER'S	